

7 May 1999
DRAFT

Quality Assurance

for ATLAS MDT Chamber Construction

Task Owner QA/QC Procedures

Description of the Quality Assurance Procedures for the Construction of the Monitored Drift Tube chambers for the ATLAS muon spectrometer.

Table 1: Quality control tests of drift tube materials at the chamber production sites

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|--|---|------------------------------------|-----------|---|
| Aluminium tube visual inspection of inside and outside | no obvious defects or holes; proper cleaning, de-laminating, straightness, bar code, backing | reject tube, notify supplier | central | 1: sample test/batch 2: every tube before wiring |
| Outer diameter envelope, from 8 points on circumference | 23370 \pm 15 μ m | reject box | central | sample test/batch |
| Wall thickness, at 8 points on circumference | 130 \pm 30 μ m | reject box | central | sample test/batch |
| Length l | $l = 0.5$ mm ($l \leq 1$ m) $l = 0.7$ mm ($l > 1$ m) | reject box | central | sample test/batch |
| Straightness | insertion in 24 without difficulties | reject tube, notify supplier | central | sample test/batch |
| Wire visual inspection | no defects of gold-plating, proper cleaning, no kinks | reject spool | central | 1: first meters and every 100 m per spool under microscope; 2: inspection during wiring |
| Knurling visual inspection | proper cleaning and no obvious defects of plastic; O-rings, wire locator, AI reference surface, crimps tube | reject endstop, notify supplier | central | 1: sample test/batch 2: each endstop before wiring |
| Outer diameter envelope, from 8 points on circumference (optional) | 33020 \pm 10 μ m | reject batch | central | sample test/batch |
| Wire locator outer diameter | within tolerance | reject batch | central | sample test/batch |

Table 2: Quality control tests of drift tubes at the chamber production sites

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|--|---|---|-----------|--|
| Drift tube visual inspection | no obvious damage of tube or endplug, no visible defects of tube and wire crimps, tube correctly sealed | reject tube, adjust wiring station | local | each tube after wiring, before chamber assembly |
| Minimum tube outer diameter envelope in endplug region | less than 30.020 mm | adjust wiring setup | local | sample test/day after wiring |
| Length l | $l = 0.5$ mm at $20 - 15^{\circ}\text{C}$ | reject drift tube, adjust wiring station | local | 1: sample test/day 2: each tube on chamber assembly jig |
| Relative azimuthal orientation of endplugs | -10 mrad | reject drift tube, adjust wiring station | local | 1: sample test/day 2: each tube on chamber assembly jig |
| Straightness | insertion in jig without difficulties | reject drift tube | local | 1: sample test/day 2: each drift tube during chamber assembly |
| Ground contact resistance | less than 100 m Ω | repeat laser welding | local | 1: sample test/day 2: monitoring of selected tubes over time |

Table 3: Quality control tests for all drift tubes at the chamber production sites

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|---|--|--|-----------|--|
| Drift tube | | | | |
| Room temperature | $20 \pm 2^\circ\text{C}$ | adjust | local | during tube tests |
| Relative humidity (optional) | | | local | monitoring |
| Temperature of tube | $20 \pm 1^\circ\text{C}$ | adjust temperature or tension | local | during tube assembly |
| Temperature of tube | known within $\pm 1^\circ\text{C}$ | repeat measurement | central | during wire tension measurement |
| Wire tension (oscillation frequency) | within $\pm 5\%$ of the nominal value at $20 \pm 1^\circ\text{C}$ | reject drift tube | central | 1: shortly after tube wiring 2: after min. two months, before assembly |
| Wire location at the tube ends | within $\pm 25 \mu\text{m}$ of the center of the endplug ref. surface in 1 and 2 | reject drift tube; inspect endplugs and wiring station | central | sample test on day of wiring; tube held as in assembly (3); incl. test of co-axiality of endplugs; measurements at 0 and 150° |
| Gas pressure test at 3 bar overpressure | no obvious leaks | reject drift tube; inspect endplugs; adjust wiring station | local | |
| Gas leak rate at 2 bar overpressure | less than 10^{-2} bar L/s | reject drift tube; inspect endplugs; adjust wiring station | central | after pressure test |
| HV stability test: leakage current | less than 2 nA/m | reject drift tube; inspect endplugs; tubes, wire | central | with Ar:CO ₂ (33:7) at 3 bar and 3100 V |
| HV stability test: cosmic count rate (optional) | within $\pm 3\%$ of nominal value | reject drift tube; inspect endplugs; tubes, wire | central | with Ar:CO ₂ (33:7) at 3 bar and 3100 V |

Table 4: Diff. tube test equipment at the production sites

| Site | Wire tension (max. frequency) | Wire position | Leak rate (whole tube) | IV test (leakage current) | IV test (cosmic rate) |
|-----------------------------|--|--|--|--|-----------------------|
| Freiburg | Excitation in B-field | Brandeis X-ray system | Leak detector with single-tube containers | IV system with pA-meter | Yes |
| LMU/MPI (accept. test) | CAEN SY302 meter; excitation in B-field | Brandeis X-ray system, MPI 3g | Pressure rise in evacuated volume at endpup (S tubes sim.) | IV system with 1 nA sensitivity | BNI, preatmp., shaper |
| NTU Athens | CAEN SY302 meter; excitation in B-field | Brandeis X-ray system | As Pavia | As Pavia | |
| Univ. Athens | | | as NTU Athens (after module 2) | | |
| Thessaloniki (accept. test) | excitation in B-field | | | CAEN SY127 (13 channels); 1 nA sensitivity; IV system | |
| Prascati | Electrostatic excit.; multi-channel system; integration with leak test | Electronoagnetic micro-meter; as Pavia, Rome | Helium leak detector; 30 single-tube containers | CAEN SY303 (3s channel); 1 nA sensitivity; IV system; integration with leak test | Yes |
| Cosenza | CAEN SY302 meter; excitation in B-field; integration with leak test | Electronoagnetic micro-meter; as Pavia, Rome | As Pavia; automatic control system | CAEN SY303 (3s channel); 1 nA sensitivity; IV system; integration with leak test | |
| Pavia | As Rome | Electronoagnetic micro-meter | Argon mass spectrometer; 10 single-tube containers (commercial system) | IV system (13 channels) with pA-meter; integration with leak test | |
| Rome | Excitation in B-field; multi-channel | Electronoagnetic micro-meter | As Frascati or Pavia; | As Pavia | |
| NIKHEF | Mechanical excitation; piezoelectric measurement | Electronoagnetic; as Pavia/Rome | Helium leak detector; multi-tube container | Multi-channel IV system; integration with leak test | Yes |
| Dubna (also for MPI) | Excitation in B-field; meter custom design | Brandeis X-ray system, MPI 3g | Helium mass spectrometer; multi/single-tube containers | CAEN SY303 (3s channel); 1 nA sensitivity; IV system | BNI, preatmp., shaper |
| Protvino | Excitation in B-field; meter custom design | Brandeis X-ray system | Mass spectrometer | | |
| Boston | Excitation in B-field; meter custom design | Brandeis X-ray system | Mass spectrometer; multi-tube container | Multi-channel IV system; integration with leak test | Yes |
| Michigan | As Seattle | Electronoagnetic micro-meter; as Pavia, Rome | Helium leak tester; evacuated volume at endpup and moving along tube | Multi-channel IV system | |
| Seattle | Excitation in B-field; meter custom design | Electronoagnetic; as Pavia/Rome | As Michigan | As Michigan | |

Table 5: Quality control tests during chamber assembly.

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|--|------------------------------------|--------------------|-----------|---|
| Environment | | | | |
| Room temperature | 20 – 15°C | adjust | local | before gluing |
| Relative humidity | 50 – 10 % | adjust | local | before gluing |
| Atmospheric pressure (optional) | | | local | monitoring |
| Temperature of outer cross plates | 20 – 0.5°C | adjust | local | uniform, before gluing |
| Temperature of end combs | 20 – 0.5°C | adjust | local | uniform, before gluing |
| Temperature difference outer cross plates+end combs | < 0.2°C | adjust | local | during gluing |
| Spacer assembly | | | | |
| Glue gaps between tube layer on combs and cross plates | 200 – 1000 µm | adjust | local | both orientations of cross plates around 2-axis |
| On-chamber gas system | | | | |
| Leak rate | less than 10 ⁻⁹ bar l/s | repair | local | of preassembled gas manifolds |
| Flow rate/tube | to be specified | repair | | for preassembled gas manifolds |

Table 6: Quality control tests during chamber assembly (cont.)

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|--|--|----------------------|-----------|--|
| Assembly of tube layers Vacuum section underpressure | at nominal value | adjust | local | tube positioning on cones during gluing |
| Horizontal gaps between tubes | not more than two adjacent tube walls touching; no adjacent endflaps touching | relocate drift tubes | local | before gluing |
| Height of endflap reference surfaces | within $\pm 10 \mu\text{m}$ of nominal value in ϕ | relocate drift tubes | local | before gluing |
| Stability of in-plane monitor readings (in case displacement) Sphere locations | within $\pm 10 \mu\text{m}$ of nominal value in ϕ and z | adjust | central | after each gluing step (definition of zero of in-plane monitors); after correction for misalignment |
| Outer cross plate sags on the assembly table (optional) | within $\pm 10 \mu\text{m}$ of nominal value in ϕ and z | adjust | local | before each gluing step; with sphere and in-plane monitors |
| Outer cross plate sags on the assembly table (optional) | zero within $\pm 10 \mu\text{m}$ | adjust | local | before gluing of a layer; measured with temporary cross plate sag monitors |
| Middle cross plate sag on the assembly table (optional) | zero within $\pm 20 \mu\text{m}$ | adjust | local | before gluing of a layer; measured with in-plane monitors plus outer cross plate sag correction |
| Alignment Platforms | | | | |
| Angular alignment of axial/per axial platforms | within $\pm 80 \mu\text{rad}$, $\pm 200 \mu\text{rad}$, $\pm 80 \mu\text{rad}$ around x , y , z -axes with chamber coord. axes; orthog. $\pm 100 \mu\text{rad}$; cross plate length | store data | central | after each gluing step (initially); tolerances incl. errors in rec. of thermal and gravitational deformations with in-plane system |
| Angular alignment of projective platforms | within $\pm 200 \mu\text{rad}$, $\pm 80 \mu\text{rad}$, $\pm 80 \mu\text{rad}$ around x , y , z -axes with chamber coordinate axes | store data | central | tolerances incl. errors in rec. of thermal and gravitational deformations with in-plane system |

Table 7: Quality control tests of all assembled charabets at the production sites

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|--|---|---|-----------|--|
| Mechanical Tests | | | | |
| Sag of charabter on kinematical supports before sag compensation | | store data | central | σ readings of in-plane moments |
| Sag of charabter on kinematical supports after sag compensation | within $\pm 20 \mu\text{m}$ of nominal wire sag | adjust sag compensation until within tolerance; store data | central | σ readings of in-plane moments |
| Deformation of cross plates on kinematical supports (recommended for IEM, IO) | $< 20 \mu\text{m}$ | store data | central | with temporary cross plate sag moments and ICA model |
| Rel. angular alignment of alignment platforms on kinematical supports after sag compensation | see Table 3 | store data | local | includes accuracy of reconstruction of thermal and gravitational deformations with in-plane system |

Table 8: Quality control tests of all assembled chambers at the production sites (cont.)

| Test | Acceptance criteria | Reaction if failed | Data base | Comment |
|--|--|---|-----------|--|
| Operation Tests | | | | |
| Gas pressure test at 3 bar overpressure | test done; no obvious leaks | repair gas manifold; repair/disconnect family inlets; store II) | central | |
| Gas leak rate at 2 bar overpressure | less than 2×10^{-9} bar l/s per inlet | repair gas manifold; repair/disconnect family inlets; store II) | central | after pressure test |
| HV stability; leakage current | less than 2 nA/ro \rightarrow 5 nA per channel | replace electronics boards; identify; sparger/disconnect family drift inlets; store II) | central | with installed electronics boards; baseline gas at 3 bar and nominal and 80% nominal gas gain |
| HV stability; cosmic count rate (optional) | within $\pm 3\%$ of nominal value | identify noisy channels; store II) | local | with installed electronics boards; baseline gas at 3 bar and nominal gas gain |
| Operation in cosmic ray test stand | evaluation of performance; noise level; efficiency; random rate; max. drift time; resolution vs. γ ; uniformity; local wire displacement; stable performance of all channels over 1–2 weeks | make chamber operational; store II) of family inlets | local | with test electronics; baseline gas at 3 bar and nominal gas gain |
| Wire location measurement with cosmic rays (optional) | no systematic deviations from expected wire grid | store wire location data incl. meas. errors; adjust assembly tooling in case of deviations | central | track reconstruction in cosmic ray lower |

Table D: Quality control tests of all assembled chambers after transport to CERN and during storage

| Test | Acceptance criteria | Reaction on failure | Data base | Comment |
|-------------------------------|--|---|-----------|---|
| Visual inspection | no visible damage | perform possible repairs; mark chamber for X-ray tomograph and full leak test | | acceptance test after transport to CERN |
| Gas leak rate at 3 bar | less than 2×10^{-9} bar l/s per inlet | repair gas manifold; repair/disconnect faulty inlets; store II) | central | 1: full leak test for one chamber per transport to CERN (acceptance test) or if visible damage of chamber 2: monitoring of pressure (at known temperature) over storage time |
| HV stability; leakage current | less than 5 nA/channel | replace electronics boards; identify disconnect faulty inlets; store II) | central | after mounting of final electronics; with baseline gas at 3 bar and nominal and $2 \times$ nominal gas gain |
| Operating test | evaluation of performance: pulser test (correct connections); signal from all channels; noise level; random rate; uniformity | replace electronics; make chamber operational | local | after mounting of final electronics; with baseline gas at 3 bar and nominal operating conditions |

Table 10: Quality control tests of selected chambers from each production site after transport to CERN and during storage

| Test | Acceptance criteria | Reaction on failure | Data base | Comment |
|---|---|---|-----------|---|
| Wire location measurement with X-ray tomograph (incl. location of wire on the 4light. platform) | $-20 \mu\text{m}$ rms in x and y with respect to the expected wire grid | store wire location data and chamber ID; adjust assembly tooling in case of deviations; measure chambers since problem first detected | central | 1: sample test/production site 2: for chambers with expected mechanical problems |
| Wire tension (osc. frequency) | within $\pm 5\%$ of the nominal value at given temperature | store data; notify production sites; measure other chambers | central | for one chamber/production site at regular intervals over storage time (temperature meas. to -1°C) |
| Inter ground contact resistance | less than $100 \text{ m}\Omega$ | store data; notify production sites; measure other chambers | central | for one chamber/production site at regular intervals over storage time |